Notice of References Cited Application/Control No. 10/619,371 Examiner Marina Lamm Applicant(s)/Patent Under Reexamination LERMA, SHELAH M. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|-------------------------|----------------|
| * | Α | US-4,593,038 | 06-1986 | Burzynski, Stanislaw R. | 514/328 |
| * | В | US-5,916,573 | 06-1999 | Spiers et al. | 424/401 |
| * | С | US-5,997,876 | 12-1999 | Shikhashvili et al. | 424/730 |
| * | D | US-6,197,305 | 03-2001 | Friedman et al. | 424/737 |
| * | ш | US-6,315,980 | 11-2001 | Denda et al. | 424/9.2 |
| * | ш | US-6,368,639 | 04-2002 | Farooqi et al. | 424/725 |
| * | G | US-6,576,269 | 06-2003 | Korneyev, Alexander Y. | 424/725 |
| * | Ŧ | US-6,906,106 | 06-2005 | Chevalier, Veronique | 514/690 |
| * | _ | US-6,986,903 | 01-2006 | Zulli et al. | 424/450 |
| * | 7 | US-2002/0114820 | 08-2002 | Deckers et al. | 424/401 |
| * | Κ | US-2003/0232094 | 12-2003 | Fuller, Peter E. | 424/717 |
| * | L | US-2004/0031500 | 02-2004 | Reyzis, Michael | 132/200 |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|--------------|-------------------|----------------|
| | N | SU 1683750 A1 | 10-1991 | Soviet Union | ALTYMYSHEV et al. | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|----------|-------------------------------------------------------------------------------------------|
| | U | |
| | v | |
| | w | |
| | × | |

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.